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				First Named Inventor	Sam-Chul HA
				Art Unit	2471
				Examiner Name	Albert T. Chou
Sheet	1	of	1	Attorney Docket Number	7950.036.00

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Examiner Initials*	Cite No. ¹	Document Number	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
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NON PATENT LITERATURE DOCUMENTS					
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